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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

ART UNIT:

SERIAL NO.: 10/535,358

EXAMINER:

FILED:

FOR:

Andrew R. Barow and
Elizabeth Ann Whitsitt

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10/535,358

Method for Low Temperature
Growth of Inorganic Materials From \$
Solution Using Catalyzed Growth Solution Using Catalyzed Growth

And Re-Growth

CONFIRMATION NO.:

INFORMATION DISCLOSURE STATEMENT

Atty. Dkt. No.: 1789-09405 CWS

Clt. Ref. No.: 21050 Date: January 11, 2006

Mail Stop Amendment Commissioner for Patents P. O. Box 1450 Alexandria, Virginia 22313-1450

Sir:

This Information Disclosure Statement, including completed Form PTO-1449, comprises a list of pertinent art of which Applicants are aware.

The submission of this Information Disclosure Statement and the references submitted therewith is not an admission that the art cited is "prior" with respect to the present invention, nor is it a representation, that no better art exists. Applicants hereby reserve the right to swear behind or otherwise disprove any alleged "prior" nature of any art cited should the facts support and the situation warrant such an action. It is submitted that the art cited does not constitute a bar to the patentability of Applicants' invention under 35 U.S.C. § 102 or § 103.

No Office Action on the merits has been received in the present application, and Applicant believes that no fee is due. In the event that an Office Action dated prior to the mailing date of this Information Disclosure Statement has been issued, please charge Deposit Account 03-2769, Conley Rose, P.C., in the amount of \$180, so that this Information Disclosure Statement may be considered under Rule 1.97(c).

Respectfully submitted,

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Form 1449A/PTO Substitute for form 1449A/PTO 10/535.358 Application Number INFORMATION DISCLOSURE Filing Date STATEMENT BY APPLICANT Andrew R. Barron First Named Inventor Group Art Unit (use as many sheets as necessary) Examiner Name I Attorney Docket Number 1789-09405 (21050) CWS U.S. PATENT DOCUMENTS Cite Document Number Pages, Columns, Lines, Where No. Number-Kind Code 2 (if known) Date Name of Patentee or Applicant Relevant Passages or Relevant Figures Appear MM-DD-YYYY of Cited Document AAUS-6,080,683 06/27/2000 AΒ 12/17/1991 US-5,073,408 AC US-5,132,140 07/21/1992 ΑD 04/01/1997 US-5,616,233 ΑE 08/28/1984 US-4, 468,420 ΑF US-4,693,916 09/15/1987 AG US-4,431,683 02/14/1984 ΑH US-2,505,629 04/25/1950 FOREIGN PATENT DOCUMENTS Cite Foreign Patent Document T⁶ Name of Patentee or Applicant **Publication Date** Pages, Columns, Lines, Where Country Code3 Number 4- Kind Code5 of Cited Document RelevantPassages or Relevant MM-DD-YYYY (if known) Figures Appear

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		OTHER PRIOR ART I	NON PATENT LI	TERATURE DO	CUMENT	S		
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate) title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, page(s), volume-issued number(s), publisher, city and/or country where published.						
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Examiner Signature				Dated Considere	d		<u> </u>	